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#### **Key indicators**

Single-crystal X-ray study T = 293 K Mean  $\sigma$ (C–C) = 0.003 Å R factor = 0.045 wR factor = 0.138 Data-to-parameter ratio = 15.8

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

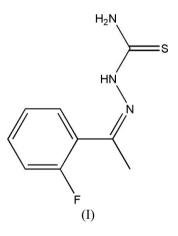
## The title compound, $C_9H_{10}FN_3S$ , was prepared by the reaction of thiosemicarbazide with *o*-fluoacetophenone at room temperature. The packing is stabilized by intra- and intermolecular hydrogen bonds.

1-[1-(2-Fluorophenyl)ethylidene]thiosemicarbazide

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## Comment

Schiff bases have been used extensively as ligands in the field of coordination chemistry (Jian *et al.*, 2006). They are potential antimicrobial and anticancer agents (Tarafder *et al.*, 2000; Deschamps *et al.*, 2003) and so have biochemical and pharmacological applications. The recent growing interest in Schiff bases is also due to their ability to form intramolecular hydrogen bonds by electron coupling between acid–base centres (Rozwadowski *et al.*, 1999). Here we report the crystal structure of the title compound, (I).



In (I) (Fig. 1), the C7–N1 bond length [1.284 (2) Å] is a little shorter than that expected for a typical C—N bond (Liu *et al.*, 2002). The C–S bond length [1.691 (2) Å] is comparable with the values observed for a C—S double bond (Jian *et al.*, 2005). The dihedral angles formed by the mean plane through the N1/N2/C7/C8 system with the thiosemicarbazide fragment (S1/N2/N3/C9) and the benzene ring are 11.62 (10) and 49.99 (9)°, respectively.

The molecular structure is stabilized by intramolecular C– H $\cdots$ F and N–H $\cdots$ N hydrogen bonds (Table 1). In the crystal packing, the molecules are linked into two-dimensional layers by intermolecular N–H $\cdots$ S hydrogen-bond interactions (Table 1).

### **Experimental**

© 2007 International Union of Crystallography All rights reserved A mixture of thiosemicarbazide (0.02 mol) and hydrochloric acid (0.02 mol) was stirred in ethanol (30 ml) for 10 min, then *o*-fluoro-

acetophenone (0.02 mol) was added and the resulting mixture was stirred at 293 K for 2 h to afford the title compound (2.28 g, yield 54%). Single crystals suitable for X-ray measurements were obtained by slow evaporation of an acetone solution at room temperature.

Z = 4

 $D_x = 1.362 \text{ Mg m}^{-3}$ 

Mo  $K\alpha$  radiation  $\mu = 0.29 \text{ mm}^{-1}$ 

Block, colourless

 $0.25 \times 0.20 \times 0.18 \text{ mm}$ 

3 standard reflections

every 100 reflections

intensity decay: none

 $w = 1/[\sigma^2(F_0^2) + (0.0808P)^2]$ 

where  $P = (F_o^2 + 2F_c^2)/3$ 

+ 0.1009P]

 $\Delta \rho_{\rm min} = -0.28~{\rm e}~{\rm \AA}^{-3}$ 

 $(\Delta/\sigma)_{\rm max} < 0.001$  $\Delta \rho_{\rm max} = 0.40 \text{ e } \text{\AA}^{-3}$ 

1591 reflections with  $I > 2\sigma(I)$ 

T = 293 (2) K

 $R_{\rm int} = 0.023$  $\theta_{\rm max} = 27.0^{\circ}$ 

#### Crystal data

 $C_{9}H_{10}FN_{3}S$   $M_{r} = 211.26$ Monoclinic,  $P2_{1}/c$  a = 6.4920 (13) Å b = 18.589 (4) Å c = 8.6000 (17) Å  $\beta = 97.03$  (3)° V = 1030.0 (4) Å<sup>3</sup>

### Data collection

Enraf–Nonius CAD-4 diffractometer ω scans Absorption correction: none 2381 measured reflections 2193 independent reflections

### Refinement

Refinement on  $F^2$   $R[F^2 > 2\sigma(F^2)] = 0.045$   $wR(F^2) = 0.138$  S = 1.092193 reflections 139 parameters H atoms treated by a mixture of independent and constrained refinement

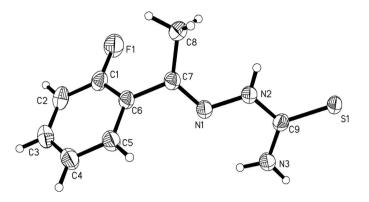
 Table 1

 Hydrogen-bond geometry (Å, °).

$D - H \cdots A$	D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdot \cdot \cdot A$
$\overrightarrow{N3-H3B\cdots N1}$ $C8-H8A\cdots F1$ $N2-H2A\cdots S1^{i}$ $N3-H3A\cdots S1^{ii}$	0.85 (3)	2.22 (2)	2.595 (2)	107 (2)
	0.96	2.53	2.979 (3)	109
	0.85 (3)	2.82 (3)	3.665 (2)	173 (2)
	0.92 (2)	2.59 (2)	3.506 (2)	169 (2)

Symmetry codes: (i) -x, -y + 1, -z; (ii) -x, -y + 1, -z + 1.

H atoms attached to N atoms were located in a difference Fourier map and refined freely. All other H atoms were positioned geometrically and allowed to ride on their parent atoms, with C–H = 0.93–0.96 Å and with  $U_{\rm iso}({\rm H}) = 1.2$  or 1.5 times  $U_{\rm eq}({\rm C})$ .



### Figure 1

The molecular structure and atom-labelling scheme for (I), with displacement ellipsoids drawn at the 30% probability level.

Data collection: *CAD-4 Software* (Enraf-Nonius, 1989); cell refinement: *CAD-4 Software*; data reduction: *NRCVAX* (Gabe *et al.*, 1989); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *SHELXTL/PC* (Sheldrick, 1990); software used to prepare material for publication: *WinGX* (Farrugia, 1999).

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